N-Channel 30V, 12mΩ Typ. Power MOSFET

Description

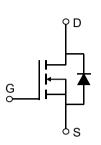
Features

• 30V, 9A

 $R_{DS(ON)}$ Typ = $12m\Omega$ @ V_{GS} = 4.5V

 $R_{DS(ON)}$ Typ = 14.5m Ω @ V_{GS} =2.5V

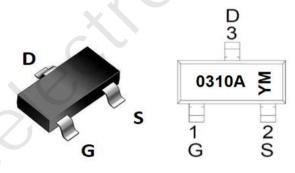
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free





Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMJTU0310A	0310A	SOT-23-3L	TAPING	7"	3000	120000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		30	V
V _{GS}	Gate-to-Source Voltage		±12	V
_	Continuous Drain Current	T _A = 25°C	9	А
I _D		T _A = 100°C	5.4	А
I _{DM}	Pulsed Drain Current (1)		36	Α
P_{D}	Power Dissipation	T _A = 25°C	2.1	W
$R_{\scriptscriptstyle{ hetaJA}}$	Thermal Resistance, Junction to Ambient ⁽²⁾	2)	58	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C

1

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Uni
Off Chara	acteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1.0	μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 12V$	-	-	±100	nA
On Chara	acteristics				G	
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.5	0.75	1.3	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽³⁾	$V_{GS} = 4.5V, I_D = 5A$	-	12	15.6	mΩ
		V _{GS} = 2.5V, I _D =3A	-	14.5	19	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		-(1444	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V,$ f = 1MHz	X - \	109	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 1101112		93	-	pF
Q_g	Total Gate Charge		<u></u> -	19	-	nC
Q_gs	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 10V, I_{D} = 9A$	-	3	-	nC
Q_gd	Gate Drain("Miller") Charge	VDS = 10 V, 10 = 371	-	4	-	nC
Switchin	g Characteristics					
$t_{d(on)}$	Turn-On DelayTime	.()	-	6	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 15V$	-	18	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	$I_D = 9A$, $R_{GEN} = 3\Omega$	-	21	-	ns
t_f	Turn-Off Fall Time		-	5	-	ns
Drain-So	urce Diode Characteristics and M	lax Ratings				
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	9	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	36	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _S = 9A		-	1.2	V
trr	Body Diode Reverse Recovery Time	I = 0.0 di/dt = 100.0/	-	7	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 9A$, di/dt = 100A/us	-	2	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



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Typical Performance Characteristics

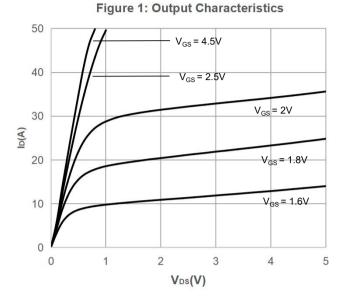


Figure 3: On-resistance vs. Drain Current

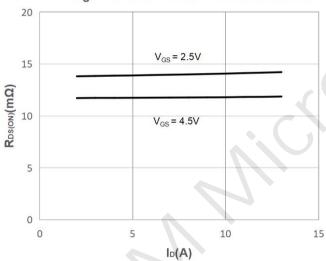


Figure 5: Gate Charge Characteristics

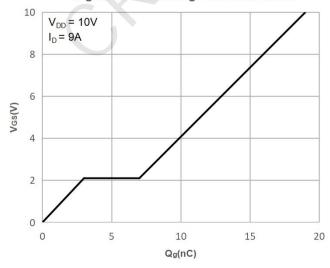


Figure 2: Typical Transfer Characteristics

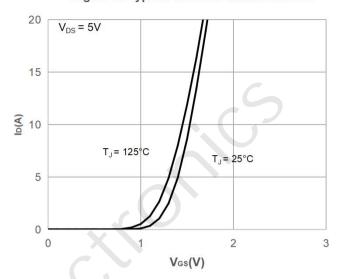


Figure 4: Body Diode Characteristics

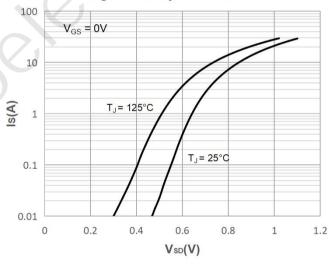
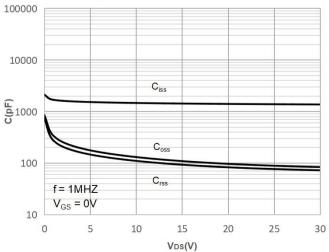


Figure 6: Capacitance Characteristics



Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs.
Junction Temperature

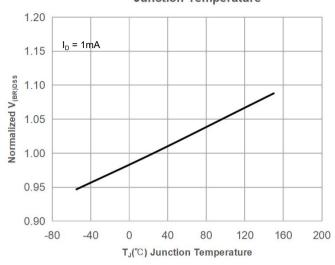


Figure 9: Maximum Safe Operating Area

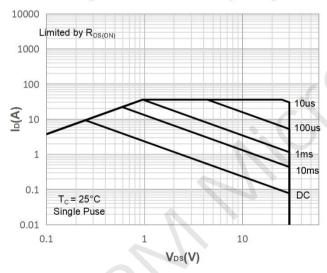


Figure 11: Normalized Maximum Transient

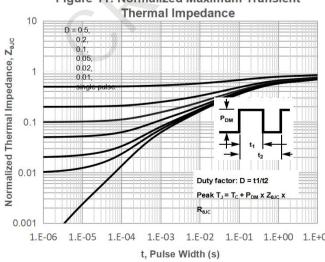


Figure 8: Normalized on Resistance vs. Junction Temperature

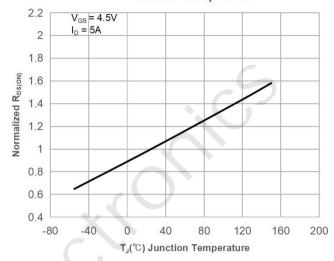


Figure 10: Maximum Continuous Drian
Current vs. Case Temperature

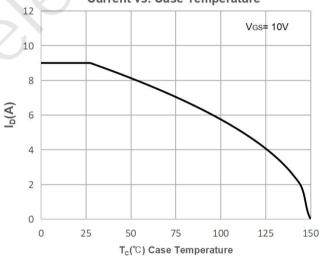
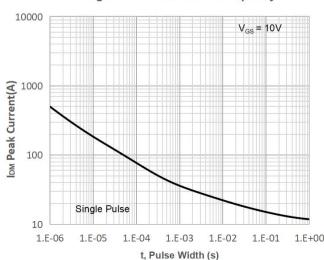


Figure 12: Peak Current Capacity



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Test Circuit

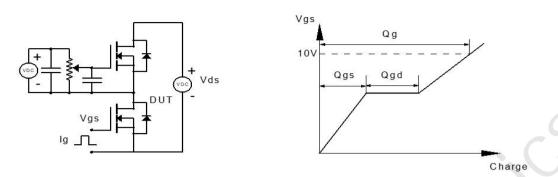


Figure 1: Gate Charge Test Circuit & Waveform

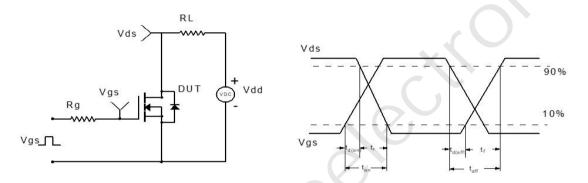


Figure 2: Resistive Switching Test Circuit & Waveform

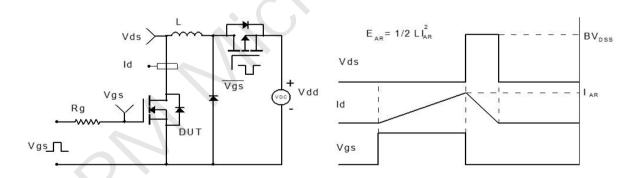


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

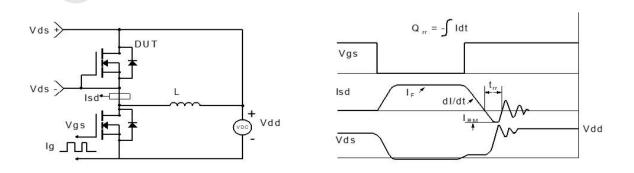
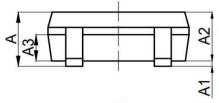
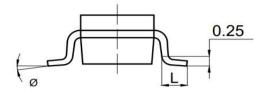


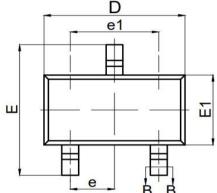
Figure 4: Diode Recovery Test Circuit & Waveform

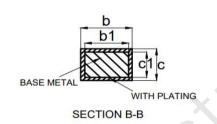
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Package Mechanical Data(SOT-23-3L)









0)/44001	MILLIMETER				
SYMBOL	MIN	NOM	MAX		
Α			1.25		
A1	0.04		0.10		
A2	1.00	1.10	1.20		
A3	0.55	0.65	0.75		
b	0.30		0.40		
b1	0.37	0.40	0.43		
С	0.11		0.21		
c1	0.10	0.13	0.16		
D	2.72	2.92	3.12		
E	2.60	2.80	3.00		
E1	1.40	1.60	1.80		
е	0.95BSC				
e1	1.90BSC				
L	0.30		0.60		
Ø	0		8°		

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